



REVISIONS			
REV.	DATE	DESCRIPTION	APD
Specification			
Item No.	TSL-532-70-200A		
Wavelength	532nm		
EFL	200mm		
BFL	248.32mm		
WD	245.32mm		
Scan angle	±14.3°		
Scan length	87mm		
Scan field	70mm×70mm		
Input beam EP	20mm		
M1-M2	28mm		
M2-lens center	99mm		
M2-mount edge	83.9mm		
Center spot size(1/e2)	7.1um		
Edge spot size(1/e2)	7.8um		
Outer diameter D	144mm		
Thread	TK133		
Total length	87.6mm		
With protective window	Yes		
Transmission	>94%		
Series No.			

TOLERANCES UNLESS SPECIFIED: ±0.05mm		NAME	DATE	WAVELENGTH TECHNOLOGY	
SURFACE: Black Anodize		DRAWN	Amoy		
MATERIAL: AL		CHECKED		DWG. NO.	REV.
UNIT: mm		TSL-532-70-200A		SL232	A
SCALE:				SHEET:	1 OF 1

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